

## Gap opening at the charge neutrality point of a graphene transistor on hBN

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We have performed magneto-transport experiments in a high-mobility graphene transistor sandwiched between h-BN in magnetic fields up to 30 T. We find an exponentially increasing resistance at the charge neutrality point (CNP) when increasing the magnetic field and/or decreasing the temperature. This behaviour suggests a field-induced gap opening at zero energy. Additionally, resistance minima at filling factors  $\nu=\pm 1$  develop for  $B > 8$  T which indicates a full lifting of the four fold degeneracy of the zero-energy Landau level [1].

In order to probe the nature of the  $\nu=0$  state in more detail, we have carried out experiments in tilted magnetic fields. Extracting the gap  $\Delta_0$  from the field and temperature dependence of the resistance at the CNP,  $R_{CNP} \propto \exp(\Delta/2K_B T)$ , yields  $\Delta \approx 3$  meV at 8 T perpendicular field which is considerably larger than the bare Zeeman splitting. Together with the fact that  $\Delta$  mainly scales with the perpendicular field component, this suggest a gap opening driven by exchange interaction, and thus,  $\nu=0$  is not spin polarized.

Adding an additional in-plane field and leaving the perpendicular field component constant leads to a slight decrease of the resistance at the CNP which can be explained by an increased spin-splitting within the two level pairs above and below zero energy [2].

[1] Y. Zhang *et al.*, Phys. Rev. Lett. **96**, 136806 (2006).

[2] A. Veligura *et al.*, Phys. Rev. B **85**, 115412 (2012).

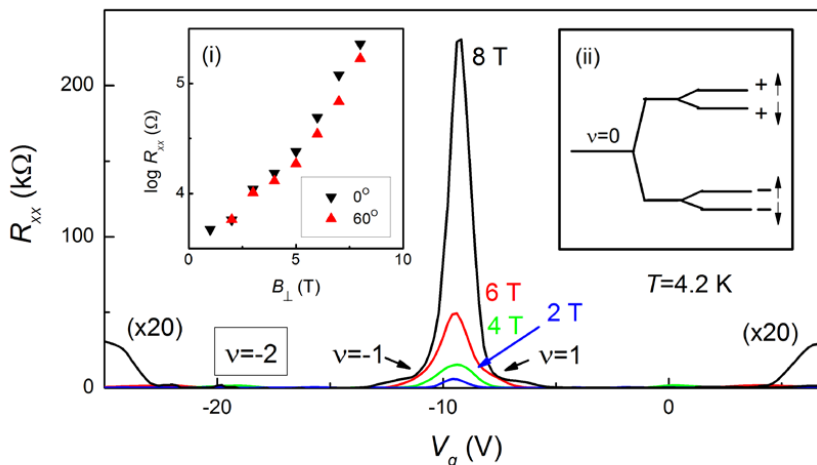


Fig. 1: Resistance as a function of gate voltage around the CNP. The inset (i) shows  $R_{CNP}$  as a function of the perpendicular field component for two tilt angles. Inset (ii) sketches the splitting scenario around  $\nu=0$ .